

#### **FEATURES AND BENEFITS**

- Fully differential architecture for improved immunity to offset drift and common mode noise
- Spare differential back end amplifier for externally adjustable gain and bandwidth using simple RC networks
- Greatly improved bandwidth through proprietary amplifier and filter design techniques
- High bandwidth 120 kHz analog output
- Patented integrated digital temperature compensation circuitry allows nearly closed-loop accuracy, through entire temperature range, in an open loop sensor
- 1.1 m $\Omega$  primary conductor resistance for low power loss and high inrush current withstanding capability
- Small footprint, low-profile QSOP24 package suitable for space-constrained applications
- Integrated shield virtually eliminates capacitive coupling from current conductor to die due to high dV/dt voltage transients

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#### Package: 24-pin QSOP (suffix LF)



#### **DESCRIPTION**

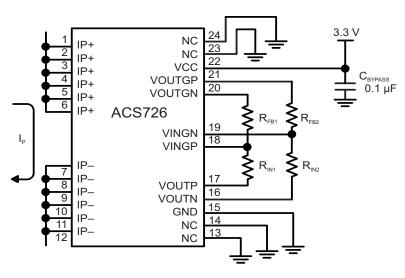
The Allegro<sup>™</sup> ACS726 current sensor IC family provides economical and precise solutions for AC current sensing in industrial, commercial, and communications systems. The device package allows for easy implementation by the customer. Typical applications include motor control, load detection and management, switched-mode power supplies, and overcurrent fault protection.

The fully differential output gives superior immunity to output offset drift as well common mode noise.

ACS726 is the first current sensor IC to include a fully differential back-end amplifier (BEA) that can be used to adjust gain and bandwidth via external RC networks. The BEA is fully independent and when unused, it can be powered down to reduce power consumption.

The device consists of a precise, low-offset, linear Hall sensor circuit with a copper conduction path located near the surface of the die. Applied current flowing through this copper conduction path generates a magnetic field which is sensed by the integrated Hall IC and converted into a proportional voltage. Device accuracy is optimized through the close proximity of the magnetic field to the Hall transducer. A

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**Typical Application** 

Current sensor IC gain can be set using  $R_{\text{FB}}$  and  $R_{\text{IN}}$ 

## Galvanically Isolated Current Sensor IC With Differential Output and Externally Adjustable Gain

#### Features and Benefits (continued)

- 3 to 3.6 V, single supply operation
- Factory-trimmed sensitivity and quiescent output voltage for improved accuracy
- Chopper stabilization results in extremely stable quiescent output voltage
- Ratiometric output from supply voltage

#### **Description (continued)**

precise, proportional voltage is provided by the low-offset, chopper-stabilized BiCMOS Hall IC, which is programmed for accuracy after packaging. The output of the device has a positive differential voltage ( $V_{\rm OUTP}-V_{\rm OUTN}$ ) when an increasing current flows through the primary copper conduction path (from pins 1 through 6, to pins 7 through 12), which is the path used for current sensing. The internal resistance of this conductive path is 1.1 m $\Omega$  typical, providing low power loss.

The terminals of the conductive path are electrically isolated from the sensor IC signal leads (pins 13 through 24). This allows the ACS726 current sensor IC to be used in high-side current sense applications without the use of high-side differential amplifiers or other costly isolation techniques.

The ACS726 is provided in a small, low-profile surface mount QSOP24 package (suffix LF). The leadframe is plated with 100% matte tin, which is compatible with standard lead (Pb) free printed circuit board assembly processes. Internally, the device is Pb-free, except for flip-chip high-temperature Pb-based solder balls, currently exempt from RoHS. The device, excluding the BAE, is fully calibrated prior to shipment from the factory.

#### **Selection Guide**

| Part Number                    | Optimized Range for<br>Sensed Current, I <sub>P</sub><br>(A) | Linear Range for<br>Sensed Current, I <sub>P</sub><br>(A) | Sensitivity,<br>Sens (Typ)<br>(mV/A) <sup>1</sup> | Operating<br>Ambient Tempera-<br>ture Range<br>T <sub>A</sub> , (°C) | Packing <sup>2</sup>   |
|--------------------------------|--|---|---|--|------------------------|
| ACS726LLFTR-20B-T <sup>3</sup> | ±20  | ±20   | 100   | -40 to 150   | Tape and reel, 2500    |
| ACS726LLFTR-40B-T <sup>3</sup> | ±40  | ±40   | 50  | 40 (0 150  | pieces per 13-in. reel |

 $<sup>^{1}\</sup>text{Measured}$  differently when  $\text{V}_{\text{CC}}$  = 3.3 V and using a 2000 mV dynamic range.



<sup>&</sup>lt;sup>2</sup>Contact Allegro <sup>™</sup> for additional packing options.

<sup>&</sup>lt;sup>3</sup> Variant not intended for automotive applications.

## Galvanically Isolated Current Sensor IC With Differential Output and Externally Adjustable Gain

#### **Absolute Maximum Ratings**

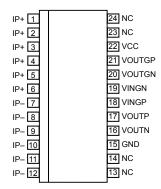
| Characteristic                 | Symbol                                       | Notes  | Rating     | Unit                      |
|--------------------------------|--|--|------------|---------------------------|
| Supply Voltage                 | V <sub>CC</sub>                              | VCC pin  | 6          | V                         |
| Reverse Supply Voltage         | V <sub>RCC</sub>                             | VCC pin  | -0.1       | V                         |
| Output Voltage                 | V <sub>OUTP</sub> , V <sub>OUTN</sub>        | VOUTP and VOUTN pins   | 6          | V                         |
| Reverse Output Voltage         | V <sub>ROUTP,</sub><br>V <sub>ROUTN</sub>    | VOUTP and VOUTN pins   | -0.1       | V                         |
| BEA Input Voltage              | V <sub>INGP,</sub> V <sub>INGIN</sub>        | VINGP and VINGIN pins  | 6          | V                         |
| BEA Reverse Input Voltage      | V <sub>RINGP</sub> ,<br>V <sub>RINGN</sub>   | VINGP and VINGN pins   | -0.1       | V                         |
| BEA Output Voltage             | V <sub>OUTGP</sub> ,<br>V <sub>OUTGN</sub>   | VOUTGP and VOUTGN pins   | 6          | V                         |
| BEA Reverse Output Voltage     | V <sub>ROUTGP</sub> ,<br>V <sub>ROUTGN</sub> | VOUTGP and VOUTGN pins   | -0.1       | V                         |
| Output Source Current          | I <sub>OUT(SOURCE)</sub>                     | VOUTP, VOUTN, VOUTGP, VOUTGN pins to GND   | 3          | mA                        |
| Output Sink Current            | I <sub>OUT(SINK)</sub>                       | VCC pin to VOUTP, VOUTN, VOUTGP, VOUTGN  | 10         | mA                        |
| Electric Strength Test Voltage | V <sub>ESTV</sub>                            | Between pins 1-12 and 13-24; 60 Hz, 1 minute (Agency Type Test), T <sub>A</sub> = 25°C                             | 2100       | VAC                       |
|                                |  | For air all mast ation according to 111 4577 atomically for binker   | 277        | VAC                       |
| Working Voltage                | V <sub>working</sub>                         | For single protection according to UL 1577 standard; for higher continuous voltage ratings, please contact Allegro | 391        | V <sub>pk</sub> or<br>VDC |
| Operating Ambient Temperature  | T <sub>A</sub>                               | Range L  | -40 to 150 | °C                        |
| Maximum Junction Temperature   | T <sub>J</sub> (max)                         |  | 165        | °C                        |
| Storage Temperature            | T <sub>stg</sub>                             |  | -65 to 170 | °C                        |

#### Thermal Characteristics may require derating at maximum conditions, see application information

| Characteristic  | Symbol          | Test Conditions*                                    | Value | Unit |  |  |  |
|---|-----------------|---|-------|------|--|--|--|
| Package Thermal Resistance (Junction to Ambient)                  | $R_{\theta JA}$ | On Allegro ACS726 evaluation board (expected value) | 27    | °C/W |  |  |  |
| *Additional thermal information available on the Allegro website. |                 |   |       |      |  |  |  |



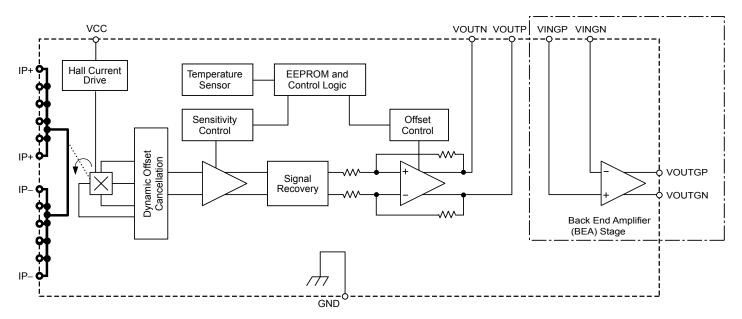
### **Pin-out Diagram and Terminal List Table**



Package LF, 24-Pin QSOP Pin-out Diagram

#### **Terminal List Table**

| Number       | Name   | Function  |
|--------------|--------|---|
| 1 through 6  | IP+    | Terminals for current being sensed; fused internally      |
| 7 through 12 | IP-    | Terminals for current being sensed; fused internally      |
| 15           | GND    | Signal ground terminal                                    |
| 16           | VOUTN  | Negative analog output                                    |
| 17           | VOUTP  | Positive analog output                                    |
| 18           | VINGP  | Gain stage positive analog input                          |
| 19           | VINGN  | Gain stage negative analog input                          |
| 20           | VOUTGN | Gain stage negative analog output                         |
| 21           | VOUTGP | Gain stage positive analog output                         |
| 22           | VCC    | Device power supply terminal                              |
| 13,14,23,24  | NC     | No Connection; connect to GND for optimal ESD performance |



**Functional Block Diagram** 



# Galvanically Isolated Current Sensor IC With Differential Output and Externally Adjustable Gain

## COMMON OPERATING CHARACTERISTICS: not including BEA, $T_A$ =-40°C to 150°C, $V_{CC}$ = 3.3 V, $C_{BYPASS}$ = 0.1 $\mu$ F; unless otherwise specified

| Characteristic  | Symbol                | Test Conditions   | Min.                  | Тур.  | Max. | Unit |
|---|-----------------------|---|-----------------------|-------|------|------|
| Supply Voltage  | V <sub>CC</sub>       |   | 3                     | 3.3   | 3.6  | V    |
| Supply Output Impedance                               | V <sub>CCIMP</sub>    |   | -                     | -     | 5    | Ω    |
| Supply Current  | I <sub>cc</sub>       | V <sub>CC</sub> = 3.3 V, no output load, BEA disabled                               | 8                     | 14    | 23   | mA   |
| Supply Current  | ICC <sub>TOTAL</sub>  | V <sub>CC</sub> = 3.0 V to 3.6 V, BEA Enabled                                       | 12                    | 22    | 40   | mA   |
| Output Capacitive Load                                | C <sub>L</sub>        | VOUTP to GND, VOUTN to GND  | -                     | _     | 4.7  | nF   |
| Output Resistive Load                                 | R <sub>L</sub>        | VOUTP to GND, VOUTN to GND  | 4.7                   | _     | _    | kΩ   |
| Primary Conductor Resistance                          | R <sub>primary</sub>  | T <sub>A</sub> = 25°C   | -                     | 1.1   | -    | mΩ   |
| Rise Time <sup>1</sup>                                | t <sub>r</sub>        | I <sub>P</sub> = I <sub>P(MAX)</sub> ; T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF | -                     | 3.7   | -    | μs   |
| Propagation Delay <sup>1</sup>                        | t <sub>pd</sub>       | $I_P = I_{P(MAX)}; T_A = 25^{\circ}C, C_L = 1 \text{ nF}$                           | -                     | 2.5   | -    | μs   |
| Response Time <sup>1</sup>                            | t <sub>RESPONSE</sub> | $I_P = I_{P(MAX)}$ ; $T_A = 25$ °C, $C_L = 1$ nF, 90% input to 90% $V_{IOUTdiff}$   | -                     | 5     | _    | μs   |
| Internal Bandwidth <sup>1</sup>                       | BWi                   | Small signal –3 dB; T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF                    | _                     | 120   | _    | kHz  |
| Linearity Error <sup>1</sup>                          | Err <sub>LIN</sub>    | Across full range of I <sub>P</sub>   | -1                    | < 0.5 | 1    | %    |
| Saturation Voltage                                    | V <sub>SAT(H)</sub>   | $T_A = 25$ °C, $R_L = 4.7 \text{ k}\Omega$ to GND                                   | V <sub>CC</sub> - 0.3 | _     | _    | V    |
| Saturation voltage                                    | V <sub>SAT(L)</sub>   | $T_A = 25$ °C, $R_L = 4.7 \text{ k}\Omega$ to VCC                                   | _                     | _     | 0.3  | V    |
| Power-On Time <sup>1</sup>                            | t <sub>PO</sub>       | $T_{A} = 25^{\circ}C,$ $I_{P} = I_{P}(MAX)$   | _                     | 85    | _    | μs   |
| Differential Quiescent Output Voltage                 | $V_{IOUTdiff(Q)}$     | I <sub>P</sub> = 0  | -                     | 0     | _    | V    |
| Common Mode Output Voltage <sup>1</sup>               | V <sub>CMO</sub>      | $I_P = 0$ , no load, $V_{CC} = 3.3 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ to 150°C | 1.4                   | 1.65  | 1.9  | V    |
| Common Mode Offset Voltage                            | V <sub>CMOE</sub>     | $I_P = 0$ , no load, $V_{CC} = 3.3 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ to 150°C | -250                  | 20    | 250  | mV   |
| Common Mode Output Voltage<br>Ratiometry <sup>1</sup> | $\Delta V_{CMORAT}$   | T <sub>A</sub> = 25C, V <sub>CC</sub> = 3.3 V +/-10%                                | -                     | 100   | _    | %    |
| Sensitivity Ratiometry <sup>1</sup>                   | ∆Sens <sub>RAT</sub>  | T <sub>A</sub> = 25C, V <sub>CC</sub> = 3.3 V +/-10%                                | _                     | 100   | _    | %    |

<sup>&</sup>lt;sup>1</sup>See Characteristic Definitions section.



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## Galvanically Isolated Current Sensor IC With Differential Output and Externally Adjustable Gain

## ACS726-20B OPERATING CHARACTERISTICS: not including BEA, $T_A$ =-40°C to 150°C, $V_{CC}$ = 3.3 V, $C_{BYPASS}$ = 0.1 $\mu$ F; unless otherwise specified

| Characteristic                                      | Symbol   | Test Conditions   | Min. | Тур. | Max. | Unit              |
|---|--|---|------|------|------|-------------------|
| Current Sensing Range                               | I <sub>P</sub>                                 |   | -20  | -    | 20   | А                 |
|   |  | Across full range of I <sub>P</sub> , T <sub>A</sub> = 25°C                       | 98   | 100  | 102  | mV/A              |
| Differential Sensitivity <sup>1</sup>               | Sens <sub>diff</sub>                           | Across full range of $I_P$ , $T_A = -40^{\circ}C$ to 25°C, not cold trimmed       | -    | 100  | _    | mV/A              |
|   |  | Across full range of I <sub>P</sub> , T <sub>A</sub> = 25°C to 150°C              | 97   | 100  | 103  | mV/A              |
| Sensitivity Drift Over Lifetime <sup>2</sup>        | $\Delta Sens_{LIFE}$                           | T <sub>A</sub> = -40C to 150C, shift after qualification testing                  | _    | ±1   | -    | %                 |
| Noise   | V <sub>NOISE(RMS)</sub>                        | BW <sub>i</sub> = 120 kHz, T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF to GND    | _    | 10.5 | -    | mV <sub>RMS</sub> |
| Input-Referenced Noise Density                      | I <sub>ND(RMS)</sub>                           | BW <sub>i</sub> ≤ 120 kHz, T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF to GND    | _    | 305  | -    | µA / √Hz          |
| Zero Current Output Voltage                         | V <sub>OUTP(Q)</sub> ,<br>V <sub>OUTN(Q)</sub> | I <sub>P</sub> = 0 A, T <sub>A</sub> = 25°C, V <sub>CC</sub> = 3.3 V              | 1.4  | 1.65 | 1.9  | V                 |
|   |  | T <sub>A</sub> = 25°C   | -15  | ±5   | 15   | mV                |
| Differential Offset Voltage <sup>3</sup>            | V <sub>OE</sub>                                | T <sub>A</sub> = -40°C to 25°C, not cold trimmed                                  | _    | ±10  | -    | mV                |
|   |  | T <sub>A</sub> = 25°C to 150°C  | -15  | ±5   | 15   | mV                |
| Offset Voltage Drift Over Lifetime <sup>2</sup>     | $\Delta V_{OELIFE}$                            | T <sub>A</sub> = -40C to 150C, shift after qualification testing                  | _    | ±2   | -    | mV                |
|   |  | I <sub>P</sub> = ±20 A, T <sub>A</sub> = 25°C, BW <sub>i</sub> = 120 kHz          | -3   | ±1   | 3    | %                 |
| Total Output Error <sup>4,5</sup>                   | Err <sub>TOT</sub>                             | $I_P$ = ±20 A, $T_A$ = -40°C to 25°C, $BW_i$ = 120 kHz, not cold trimmed          | -    | ±2   | _    | %                 |
|   |  | I <sub>P</sub> = ±20 A, T <sub>A</sub> = 25°C to 150°C, BW <sub>i</sub> = 120 kHz | -3   | ±1   | 3    | %                 |
| Total Output Error Drift Over Lifetime <sup>2</sup> | ΔErr <sub>TOTLIFE</sub>                        | T <sub>A</sub> = -40C to 150C, shift after qualification testing                  | _    | ±1   | _    | %                 |

 $<sup>^{1}\</sup>text{This}$  parameter may drift a maximum of  $\Delta \text{Sens}_{\text{LIFE}}$  over lifetime.



<sup>&</sup>lt;sup>2</sup>Based on characterization data obtained during standardized stress test for Qualification of Integrated Circuits. Cannot

be guaranteed. Drift is a function of customer application conditions. Please contact Allegro MicroSystems for further information.

 $<sup>^3</sup>$ This parameter may drift a maximum of  $\Delta V_{OELIFE}$  over lifetime.

<sup>&</sup>lt;sup>4</sup>This parameter may drift a maximum of  $\Delta$ Err<sub>TOTLIFE</sub> over lifetime.

<sup>&</sup>lt;sup>5</sup>Measured as a percentage of a 2000 mV dynamic range.

## Galvanically Isolated Current Sensor IC With Differential Output and Externally Adjustable Gain

#### ACS726-40B OPERATING CHARACTERISTICS: not including BEA, $T_A$ =-40°C to 150°C, $V_{CC}$ = 3.3 V, $C_{BYPASS}$ = 0.1 $\mu$ F; unless otherwise specified

| Characteristic                                      | Symbol   | Test Conditions   | Min. | Тур. | Max. | Unit              |
|---|--|---|------|------|------|-------------------|
| Current Sensing Range                               | I <sub>P</sub>                                 |   | -40  | -    | 40   | А                 |
|   |  | Across full range of I <sub>P</sub> , T <sub>A</sub> = 25°C                           | 49   | 50   | 51   | mV/A              |
| Differential Sensitivity <sup>1</sup>               | Sens <sub>diff</sub>                           | Across full range of $I_P$ , $T_A = -40^{\circ}C$ to 25°C, not cold trimmed           | -    | 50   | _    | mV/A              |
|   |  | Across full range of I <sub>P</sub> , T <sub>A</sub> = 25°C to 150°C                  | 48.5 | 50   | 51.5 | mV/A              |
| Sensitivity Drift Over Lifetime <sup>2</sup>        | ∆Sens <sub>LIFE</sub>                          | $T_A = -40C$ to 150C, shift after qualification testing                               | _    | ±1   | _    | %                 |
| Noise   | V <sub>NOISE(RMS)</sub>                        | $BW_i$ = 120 kHz, $T_A$ = 25°C, $C_L$ = 1 nF to GND                                   | _    | 5.25 | _    | mV <sub>RMS</sub> |
| Input-Referenced Noise Density                      | I <sub>ND(RMS)</sub>                           | $BW_i \le 120 \text{ kHz}$ , $T_A = 25^{\circ}\text{C}$ , $C_L = 1 \text{ nF to GND}$ | _    | 305  | _    | µA / √Hz          |
| Zero Current Output Voltage                         | V <sub>OUTP(Q)</sub> ,<br>V <sub>OUTN(Q)</sub> | I <sub>P</sub> = 0 A, T <sub>A</sub> = 25°C, V <sub>CC</sub> = 3.3V                   | 1.40 | 1.65 | 1.9  | V                 |
|   |  | T <sub>A</sub> = 25°C   | -15  | ±3   | 15   | mV                |
| Differential Offset Voltage <sup>3</sup>            | V <sub>OE</sub>                                | $T_A = -40$ °C to 25°C, not cold trimmed  | _    | ±8   | _    | mV                |
|   |  | T <sub>A</sub> = 25°C to 150°C  | -15  | ±3   | 15   | mV                |
| Offset Voltage Drift Over Lifetime <sup>2</sup>     | $\Delta V_{OELIFE}$                            | T <sub>A</sub> = -40C to 150C, shift after qualification testing                      | _    | ±2   | _    | mV                |
|   | Err <sub>TOT</sub>                             | I <sub>P</sub> = ±40 A, T <sub>A</sub> = 25°C, BW <sub>i</sub> = 120 kHz              | -2.5 | ±1   | 2.5  | %                 |
| Total Output Error <sup>4,5</sup>                   |  | $I_P$ = ±40 A, $T_A$ = -40°C to 25°C, $BW_i$ = 120 kHz, not cold trimmed              | _    | ±2   | _    | %                 |
|   |  | I <sub>P</sub> = ±40 A, T <sub>A</sub> = 25°C to 150°C, BW <sub>i</sub> = 120 kHz     | -2.5 | ±1   | 2.5  | %                 |
| Total Output Error Drift Over Lifetime <sup>2</sup> | ΔErr <sub>TOTLIFE</sub>                        | T <sub>A</sub> = -40C to 150C, shift after qualification testing                      | -    | ±1   | -    | %                 |

 $<sup>^{1}\</sup>text{This}$  parameter may drift a maximum of  $\Delta\text{Sens}_{\text{LIFE}}$  over lifetime.



<sup>&</sup>lt;sup>2</sup>Based on characterization data obtained during standardized stress test for Qualification of Integrated Circuits. Cannot

be guaranteed. Drift is a function of customer application conditions. Please contact Allegro MicroSystems for further information.  $^3$ This parameter may drift a maximum of  $\Delta V^{OELIFE}$  over lifetime.

 $<sup>^4\</sup>text{This}$  parameter may drift a maximum of  $\Delta\text{Err}_{\text{TOTLIFE}}$  over lifetime.

<sup>&</sup>lt;sup>5</sup>Measured as a percentage of a 2000 mV dynamic range.

### Galvanically Isolated Current Sensor IC With Differential Output and Externally Adjustable Gain

#### Differential Back End Amplifier (BEA) OPERATING CHARACTERISTICS<sup>1</sup>: T<sub>A</sub>=-40°C to 150°C, V<sub>CC</sub> = 3.3 V, C<sub>BYPASS</sub> = 0.1 μF; unless otherwise specified

| Characteristic                           | Symbol                        | Test Conditions   | Min.                  | Тур.  | Max. | Unit    |
|--|-------------------------------|---|-----------------------|-------|------|---------|
| Load                                     | ,                             |   | •                     |       |      |         |
| Output Capacitive Load                   | C <sub>L(BEA)</sub>           | VOUTGP to GND, VOUTGN to GND  | _                     | _     | 4.7  | nF      |
| Output Resistive Load                    | R <sub>L(BEA)</sub>           | VOUTGP to GND, VOUTGN to GND  | 4.7                   | _     | _    | kΩ      |
| Gain Setting Resistance                  | ,                             |   |                       | •     |      |         |
| Feedback Resistor <sup>1</sup>           | R <sub>FB(BEA)</sub>          |   | 9.4                   | _     | 50   | kΩ      |
| Input Resistor <sup>1</sup>              | R <sub>IN(BEA)</sub>          |   | 4.7                   | _     | 25   | kΩ      |
| AC Performance                           |                               |   | •                     |       |      |         |
| Open Loop Gain                           | G <sub>OL(BEA)</sub>          |   | _                     | 90    | _    | dB      |
| Closed Loop Gain <sup>2</sup>            | G <sub>CL(BEA)</sub>          |   | 2                     | _     | 10   | _       |
| Bandwidth                                | BW <sub>(BEA)</sub>           | $G_{CL(BEA)} = 2$ , $C_{L(BEA)} = 1$ nF   | _                     | 1000  | _    | kHz     |
| Gain Bandwidth Product                   | GBWP <sub>(BEA)</sub>         | C <sub>L(BEA)</sub> = 1 nF  | _                     | 2000  | _    | kHz     |
| Differential Slew Rate                   | SR <sub>D(BEA)</sub>          | $G_{CL(BEA)} = 2$ , $C_{L(BEA)} = 1$ nF   | _                     | 1.5   | _    | V/µs    |
| Settling Time to 1%                      | t <sub>S(BEA)</sub>           | $G_{CL(BEA)} = 2$ , $C_{L(BEA)} = 1$ nF,<br>$V_{OUTGP} - V_{OUTGN} = 100$ mV      | -                     | 3     | _    | μs      |
| Input-Referred Voltage Noise Density     | V <sub>ND(BEA)</sub>          | T <sub>A</sub> = 25°C, BW <sub>(BEA)</sub> < 120 kHz, G <sub>CL(BEA)</sub> = 2    | _                     | 40    | _    | nV/ √Hz |
| DC Performance                           |                               |   |                       |       |      |         |
| Input-Referred Differential Offset       | V <sub>OEIR(BEA)</sub>        | At T <sub>A</sub> = 25°C  | -7                    | ±3    | 7    | mV      |
| Voltage                                  |                               | At T <sub>A</sub> = 25°C to 150°C   | -7                    | ±3    | 7    | mV      |
| Quiescent Operating Current <sup>3</sup> | I <sub>Q(BEA)</sub>           | $G_{CL(BEA)} = 2$ , $C_{L(BEA)} = 1$ nF   | 3.5                   | 7     | 17   | mA      |
| Power Supply Rejection Ratio             | PSRR <sub>(BEA)</sub>         | $G_{CL(BEA)} = 2$ , $C_{L(BEA)} = 1$ nF, $BW_{(BEA)} < 1$ kHz                     | _                     | -70   | -    | dB      |
| Input                                    |                               |   |                       |       |      |         |
| Minimum Common Mode Input Range          | V <sub>CMIRMIN</sub><br>(BEA) | $V_{CC}$ = 3.3 V, $G_{CL(BEA)}$ = 2, $RIN_{(BEA)}$ = 4.7 K, $RFB_{(BEA)}$ = 9.4 K | 1                     | -     | _    | V       |
| William Common Wode Input Range          | V <sub>CMIRMAX</sub> (BEA)    | $V_{CC}$ = 3.3 V, $G_{CL(BEA)}$ = 2, $RIN_{(BEA)}$ = 4.7 K, $RFB_{(BEA)}$ = 9.4 K | _                     | _     | 2.15 | V       |
| Common Mode Rejection Ratio              | CMRR <sub>(BEA)</sub>         | $G_{CL(BEA)} = 2$ , $C_{L(BEA)} = 1$ nF, $BW_{(BEA)} < 1$ kHz                     | _                     | 60    | _    | dB      |
| Input Bias Current                       | I <sub>bias(BEA)</sub>        | V <sub>CC</sub> = 3.3 V, VINGP = VINGN = 1.65 V                                   | -1.5                  | <1    | 1.5  | μΑ      |
| Output                                   |                               |   |                       |       |      |         |
| Saturation Voltage                       | V <sub>SAT(H)(BEA)</sub>      | $T_A$ = 25°C, $R_{L(BEA)}$ = 4.7 kΩ to GND  | V <sub>CC</sub> - 0.3 | _     | _    | V       |
| Č  | V <sub>SAT(L)(BEA)</sub>      | $T_A = 25$ °C, $R_{L(BEA)} = 4.7 \text{ k}\Omega$ to VCC                          | _                     | _     | 0.3  | V       |
| Common Mode Output Voltage               | V <sub>CMO(BEA)</sub>         | $V_{CC}$ = 3.3 V, $G_{CL}$ = 2, $T_A$ = 25°C to 150°C                             | 1.4                   | 1.65  | 1.9  | V       |
| Common Mode Offset Voltage               | V <sub>CMOE(BEA)</sub>        | $V_{CC}$ = 3.3 V, $G_{CL}$ = 2, $T_A$ = 25°C to 150°C                             | -250                  | ±20   | 250  | mV      |
| DC Output Resistance                     | R <sub>OUT(BEA)</sub>         |   | _                     | <1    | _    | Ω       |
| Linearity                                | Err <sub>Lin(BEA)</sub>       | G <sub>CL(BEA)</sub> = 2, Over 2 V differential dynamic range                     | _                     | <±0.1 | _    | %       |

<sup>1</sup>lf larger resistor values are used, settling time deteriorates. Adding a capacitor in parallel with the feedback resistor improves settling time.



<sup>&</sup>lt;sup>2</sup>Allegro does not guarantee BAE performance and stability for Closed Loop Gain outside the recommended range.

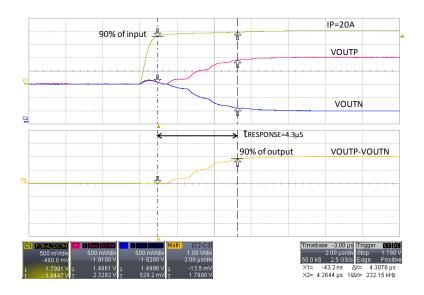
<sup>&</sup>lt;sup>3</sup>The Back End Amplifier can be powered-down by connecting VINGP and VINGN to GND, causing VOUTGP and VOUTGN to be = Vcc/2

#### CHARACTERISTIC PERFORMANCE DATA

Data taken using the ACS726LLFTR-20B-T Timing Data

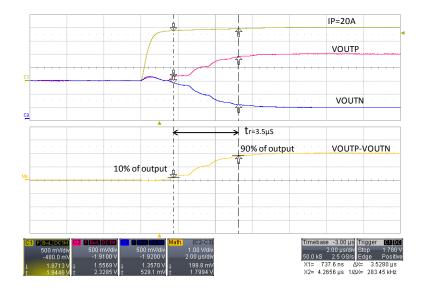
#### Response Time (90%input-90%output)

IP=20 A, 10% to 90% IP rise time < 1  $\mu$ S,  $C_{BYPASS}$  = 0.1  $\mu$ F,  $C_{L}$  =1 nF from VOUTP to GND and VOUTN to GND



#### Rise Time (10%output-90%output)

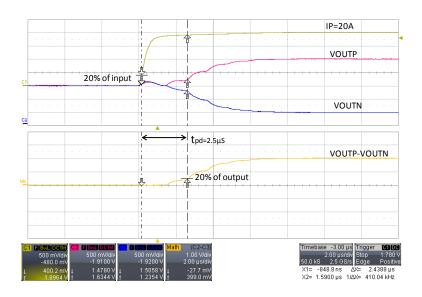
IP=20 A, 10% to 90% IP rise time < 1  $\mu$ S,  $C_{BYPASS}$  = 0.1  $\mu$ F,  $C_{L}$  = 1 nF from VOUTP to GND and VOUTN to GND



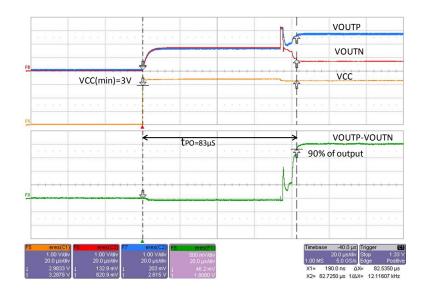


#### Propagation Delay(20%input-20%output)

IP = 20 A, 10% to 90% IP rise time < 1  $\mu$ S,  $C_{BYPASS}$  = 0.1  $\mu$ F,  $C_L$  = 1 nF from VOUTP to GND and VOUTN to GND



### Power-On Time IP = 20 A, 10% to 90% rise time < 1 $\mu$ S





#### CHARACTERISTICS DEFINITIONS

#### **Accuracy Characteristics**

**Differential Sensitivity (Sens**<sub>diff</sub>) The change in the differential sensor IC output  $(V_{OUTP} - V_{OUTN})$  in response to a 1 A change through the primary conductor. The sensitivity is the product of the magnetic circuit sensitivity (G/A) (1~G=0.1~mT) and the linear IC amplifier gain (mV/G). The linear IC amplifier gain is programmed at the factory to optimize the sensitivity (mV/A) for the full-scale current of the device.

**Noise (V\_{NOISE(RMS)})** The unfiltered output noise of the current sensor IC. Dividing the noise (mV) by the sensitivity (mV/A) provides the smallest current that the device is able to resolve.

**Linearity Error (Err<sub>LIN</sub>)\*** The ACS726 is designed to provide a linear output in response to a ramping current. Consider two current levels, I1 and I2. Ideally, the sensitivity of a device is the same for both currents, for a given supply voltage and temperature. Nonlinearity is present when there is a difference between the sensitivities measured at I1 and I2. Nonlinearity is calculated separately for the positive ( $Err_{LIN pos}$ ) and negative ( $Err_{LINneg}$ ) applied currents as follows:

$$Err_{LINpos} = 100(\%) X \left\{ I - \left( \frac{Sens_{IPOS2}}{Sens_{IPOS1}} \right) \right\}$$

$$Err_{LINneg} = 100(\%) X \left\{ I - \left( \frac{Sens_{INEG2}}{Sens_{INEG2}} \right) \right\}$$

where:

 $Sens_{Ix}$  = (V\_{IOUTdiff(Ix)} - V\_{IOUTdiff(Q)})/ Ix and IPOSx and INEGx are positive and negative currents. Then:

$$Err_{LIN} = max(Err_{LINpos}, Err_{LINneg})$$

**Differential Quiescent Output Voltage**  $(V_{IOUTdiff(Q)})^*$  The differential output of the sensor IC when the primary current is zero. It is nominally 0 V.

**Differential Offset Voltage (V<sub>OE</sub>)** The deviation of the device output, from its ideal quiescent value of 0 V, due to nonmagnetic causes. To convert this voltage to amperes, divide by the device sensitivity, Sens.

Common Mode Output Voltage ( $V_{CMO}$ ) The average of the positive and negative zero current output voltages: ( $V_{OUTP(Q)} + V_{OUTN(Q)}$ )/2.  $V_{CMO}$  nominally equals  $V_{CC}$ /2.

Common Mode Offset Voltage ( $V_{CMOE}$ ) The deviation of the Common Mode Output Voltage from its ideal value of  $V_{CC}/2$ .

**Total Output Error (ETOT)\*** The maximum deviation of the actual output from its ideal value, also referred to as accuracy, illustrated graphically in the Output voltage versus Sensed current chart.

ETOT is divided into four areas:

**0 A at 25°C.** Accuracy at the zero current flow at 25°C, without the effects of temperature.

**0** A over  $\Delta$  temperature. Accuracy at the zero current flow including temperature effects.

**Full-scale current at 25°C.** Accuracy at the full-scale current at 25°C, without the effects of temperature.

**Full-scale current over**  $\Delta$  **temperature.** Accuracy at the fullscale current flow including temperature effects.

$$E_{TOT(IP)} = 100(\%) \ X \left[ \frac{(V_{IOUT diff}(Ip) - V_{IOUT diff} \ IDEAL(Ip))}{Sens_{diff} \ IDEAL \ X \ IP} \right]$$

Where

 $V_{IOUTdiff\_IDEAL(IP)} = V_{IOUTdiff\_IDEAL(Q)} + (Sens_{diff\_IDEAL} X Ip)$ 

The Total Output Error incorporates all sources of error and is a function of  $I_P$ . At relatively high currents,  $E_{TOT}$  will be mostly due to sensitivity error, and at relatively low currents,  $E_{TOT}$  will be mostly due to Offset Voltage ( $V_{OE}$ ). In fact, at  $I_P$  = 0,  $E_{TOT}$  approaches infinity due to the offset.

This is illustrated in the total output error versus sensed current chart.

**Ratiometry** The ratiometric feature means that the Common Mode Output Voltage,  $V_{CMO}$ , and Differential Sensitivity, Sens<sub>diff</sub>, are proportional to the supply voltage,  $V_{CC}$ . The following formula is used to derive the ratiometric change in common mode 0 A output voltage,  $\Delta V_{CMORAT}$  (%).

$$100 \left( \frac{V_{\text{CMO(VCC)}} / V_{\text{CMO(3.3V)}}}{V_{\text{CC}} / 3.3 \text{ V}} \right)$$

The ratiometric change in sensitivity,  $\Delta Sens_{RAT}$  (%), is defined as:

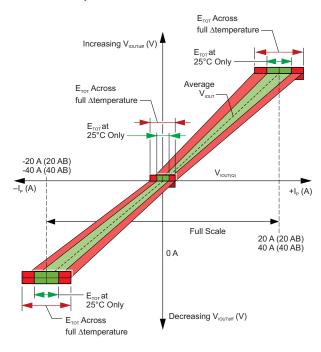
$$100 \left( \frac{\text{Sens}_{\text{diff(VCC)}}/\text{Sens}_{\text{diff(3.3V)}}}{V_{\text{CC}}/3.3 \text{ V}} \right)$$

<sup>\*</sup>Definitions of V<sub>IOUT</sub>

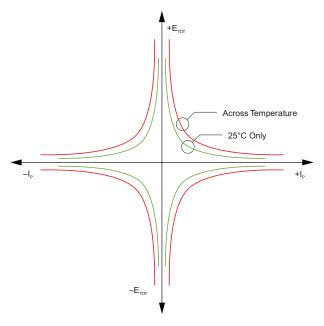
<sup>•</sup>  $V_{IOUTdiff} = V_{OUTP} - V_{OUTN}$ 

<sup>•</sup>  $V_{IOUTdiff(Q)} = V_{OUTP(Q)} - V_{OUTN(Q)}$ ; sensed current equals 0 A

#### Output Voltage versus Sensed Current Total Output Error at 0 A and at Full-Scale Current



#### **Total Output Error versus Sensed Current**





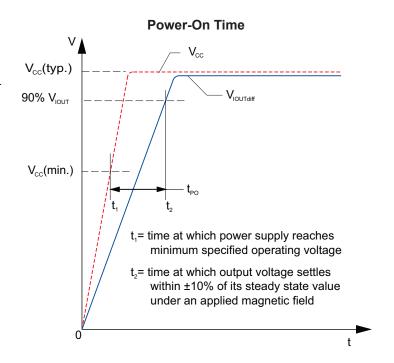
#### **Dynamic Response Characteristics**

**Power-On Time** ( $t_{PO}$ ). When the supply is ramped to its operating voltage, the device requires a finite time to power its internal components before responding to an input magnetic field. Power-On Time,  $t_{PO}$ , is defined as the time it takes for the output voltage to settle within  $\pm 10\%$  of its steady state value when full scale  $I_P$  is applied, after the power supply has reached its minimum specified operating voltage,  $V_{CC}(min)$ , as shown in the chart at right.

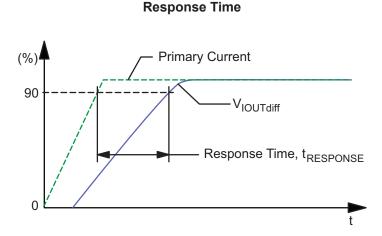
**Rise Time**  $(t_r)$  The time interval between a) when the sensor IC differential output reaches 10% of its full scale value, and b) when it reaches 90% of its full scale value.

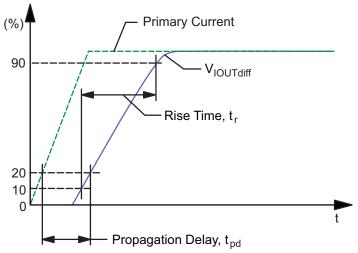
**Propagation Delay (t\_{pd})** The time interval between a) when the input current reaches 20% of it's final value, and b) when the differential output reaches 20% of its final value.

**Response Time (t<sub>RESPONSE</sub>)** The time interval between a) when the applied current reaches 90% of its final value, and b) when the sensor differential output reaches 90% of its final value corresponding to the applied current.



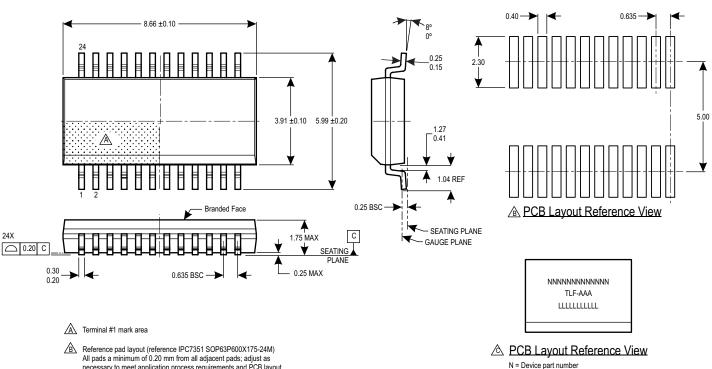
#### **Rise Time and Propagation Delay**





#### PACKAGE OUTLINE DRAWING

For Reference Only – Not for Tooling Use
(Reference JEDEC MO-137 AE)
Dimensions in millimeters – NOT TO SCALE Dimensions exclusive of mold flash, gate burrs, and dambar protrusions Exact case and lead configuration at supplier discretion within limits shown



All pads a minimum of 0.20 mm from all adjacent pads; adjust as necessary to meet application process requirements and PCB layout

A Branding scale and appearance at supplier discretion

Package LF, 24-Pin QSOP

T = Temperature code LF = (Literal) Package type A = Amperage



## Galvanically Isolated Current Sensor IC With Differential Output and Externally Adjustable Gain

#### **Document Revision History**

| Revision | Date            | Change   |
|----------|-----------------|--|
| _        | April 3, 2014   | Initial release  |
| 1        | August 13. 2014 | Removed "A" deisgnator from part number and reformatted document |
|          |                 |  |

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